Vishay Siliconix

N-Channel 40 V (D-S) MOSFET



PRODUCT SUMMARY			
V _{DS} (V)	40		
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.009		
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.0135		
Q _g typ. (nC)	5.3		
I _D (A)	36 ^g		
Configuration	Single		

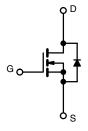
FEATURES

- TrenchFET® Gen IV power MOSFET
- \bullet Tuned for the lowest R_{DS} Q_{oss} FOM
- 100 % Rq and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



APPLICATIONS

- · Primary side switch
- DC/DC converter
- · Motor drive switch
- Boost converter
- LED backlighting



N-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK 1212-8
Lead (Pb)-free and halogen-free	SiSS4410DN-T1-GE3

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V_{DS}	40	V	
Gate-source voltage		V _{GS}	+20 / -16	V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		36		
	T _C = 70 °C	1 .	29		
	T _A = 25 °C	I _D	14 b, c		
	T _A = 70 °C	1	11.3 ^{b, c}		
Pulsed drain current (t = 100 μs)		I _{DM}	70	A	
Continuous source-drain diode current	T _C = 25 °C		18 ^a		
	T _A = 25 °C	- I _S	2.9 b, c		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	12		
Single pulse avalanche energy	L = U. I IIIH	E _{AS}	9.2	mJ	
Maximum power dissipation	T _C = 25 °C		19.8		
	T _C = 70 °C	5	12.7	w	
	T _A = 25 °C	P _D	3.2 b, c	vv	
	T _A = 70 °C	1	2.1 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	31	39	°C/W		
Maximum junction-to-case (drain)	Steady state	$R_{th,IC}$	5	6.3] C/VV		

- a. Package limited
- Surface mounted on 1" x 1" FR4 board
- t = 10 s
- See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection

 Rework conditions: manual soldering with a soldering iron is not recommended for leadless components

 Maximum under steady state conditions is 81 °C/W

- g. $T_C = 25$ °C

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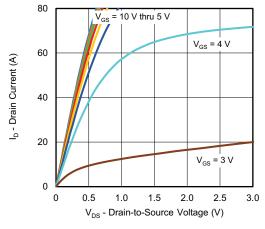
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			·			•	
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	25	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-4.4	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1.1	-	2.4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 / -16 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V	-	-	1	μА	
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 70 °C	-	-	10		
Drain-source on-state resistance ^a	_	V _{GS} = 10 V, I _D = 10 A	-	0.0067	0.009	Ω	
	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 5 A	-	0.0096	0.0135		
Forward transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 25 A	-	45	-	S	
Dynamic ^b			·			•	
Input capacitance	C _{iss}		-	850	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	168	-		
Reverse transfer capacitance	C _{rss}		-	20	-		
Tatal nata abauma	0	V _{DS} = 20 V, V _{GS} = 10 V, I _D = 10 A	-	11.5	18	nC	
Total gate charge	Q_g		-	5.3	8		
Gate-source charge	Q_{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$	-	2.9	-		
Gate-drain charge	Q _{gd}		-	0.9	-		
Output charge	Q _{oss}	V _{DS} = 20 V, V _{GS} = 0 V		6.4	-		
Gate resistance	R_g	f = 1 MHz	0.6	3.2	6.4	Ω	
Turn-on delay time	t _{d(on)}		-	7	15		
Rise time	t _r	$V_{DD} = 20 \text{ V}, R_{I} = 2 \Omega, I_{D} \cong 10 \text{ A},$	-	3	10		
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	16	30		
Fall time	t _f		-	3	10		
Turn-on delay time	t _{d(on)}		-	14	30	ns	
Rise time	t _r	$\begin{split} V_{DD} = 20 \text{ V}, \text{ R}_L = 2 \Omega, \text{ I}_D &\cong \text{10 A}, \\ V_{GEN} = 4.5 \text{ V}, \text{ R}_g = \text{1 }\Omega \end{split}$	-	8	170] -	
Turn-off delay time	t _{d(off)}		-	13	30		
Fall time	t _f		-	6	15		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	IS	T _C = 25 °C	-	-	18	А	
Pulse diode forward current	I _{SM}		-	-	70] ^	
Body diode voltage	V_{SD}	I _S = 10 A, V _{GS} = 0 V	-	0.82	1.1	V	
Body diode reverse recovery time	t _{rr}		-	12	30	ns	
Body diode reverse recovery charge	Q_{rr}	1 10 A di/dt 100 A/va T 05 °C	-	4.1	10	nC	
Reverse recovery fall time	t _a	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C	-	7	-		
Reverse recovery rise time	t _b		-	5	-	ns	

Notes

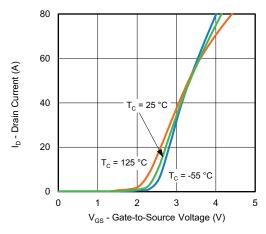
- a. Pulse test: pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

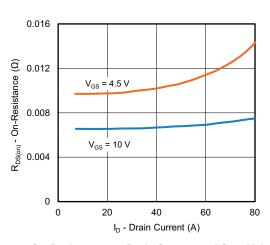




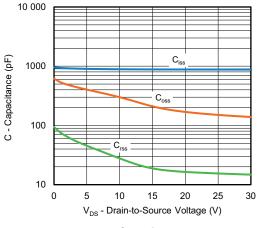
Output Characteristics



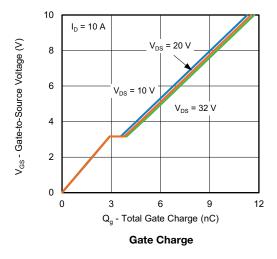
Transfer Characteristics

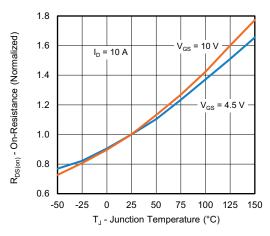


On-Resistance vs. Drain Current and Gate Voltage



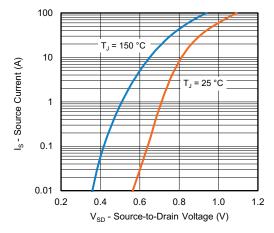
Capacitance



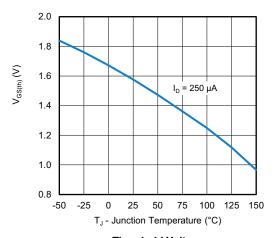


On-Resistance vs. Junction Temperature

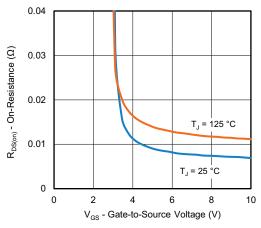




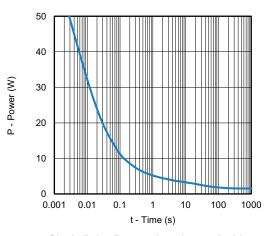
Source-Drain Diode Forward Voltage



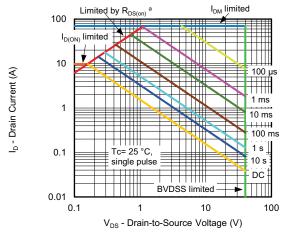
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

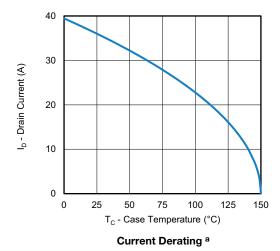


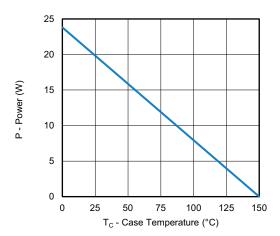
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient





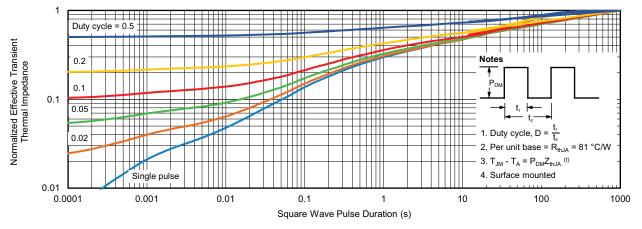


Power, Junction-to-Case

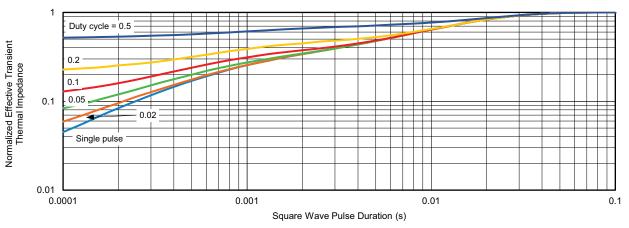
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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